

FORM HDP-1449 (Based on Form PTO-1449)

**PATENT AND TRADEMARK OFFICE**  
**INFORMATION DISCLOSURE CITATION**  
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Sheet 1 of 1

ATTORNEY DOCKET NO.	SERIAL NO.
9319S-000565	10/691,438
APPLICANT	
Kazuyoshi SAKAI	
FILING DATE*	GROUP
October 22, 2003	2871

**U.S. PATENT DOCUMENTS**

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.	AS	6,249,082	6/19/2001	Fukuyoshi, et al.		

**FOREIGN PATENT DOCUMENTS**

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes No
1.	AS	1999-67926	8/25/1999	Korea		<input checked="" type="checkbox"/> X

**OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)**

Ref. Desig.	Examiner's Initials	
1.	AS	Communication from Korean Patent Office regarding counterpart application.

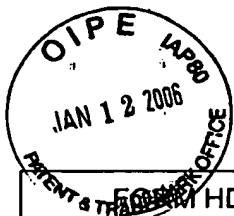
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Examiner:

*Andrew Schuttler*

Date Considered:

3/29/06



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**FOREIGN PATENT DOCUMENTS**

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation *	
						Yes	No
1.	AB	2002-116312	4/19/2002	Japan	—	X	
2.	AB	2000-147540	5/26/2000	Japan	—	X	
3.	AB	09-305126	11/28/1997	Japan	—	X	
4.	AB	09-304787	11/28/1997	Japan	✓	X	

**OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)**

Ref. Desig.	Examiner's Initials	
1.	AB	Communication from Japanese Patent Office regarding related application.

\*One or more of the English translation documents submitted herewith may be Abstracts only or partial machine created translations from the Japanese Patent Office. As such, the submitter does not necessarily vouch for their accuracy. Additional information may be obtained from the Japanese Patent Office web site at [www.jpo.go.jp](http://www.jpo.go.jp)

Examiner:

Date Considered:

1/24/06

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